Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
09/888,421	LEE ET AL.
Examiner	Art Unit
Hong Cho	2662

	SEAR	CHED	
Class	Subclass	Date	Examiner
370	249, 250, 401, 251, 360	5/13/2005	нс
709	224	5/13/2005	НС
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
370	250	5/13/2005	НС
	401	5/13/2005	нс

SEARCH (INCLUDING SEAF	NOTES RCH STRATEG	Y)
	DATE	EXMR
consulted Hassan Kizou	5/13/2005	нс
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